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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/073,751	02/09/2002	Arjun Kar Roy	01CON211P	4492	
25700	7590 07/14/2004		EXAMINER		
	& FARJAMI LLP	CHU, CHRIS C			
	LAMEDA AVENUE, SU /IEJO, CA 92691	ART UNIT	PAPER NUMBER		
	,		2815		
			DATE MAILED: 07/14/200		

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	10/073,751	KARROY ET AL.	
Office Action Summary	Examiner	Art Unit	
	Chris C. Chu	2815	
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence addr	'ess
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE date of this communication, even if timely filed	nely filed  s will be considered timely. the mailing date of this comi D (35 U.S.C. § 133).	
Status			
<ul> <li>1) Responsive to communication(s) filed on 12 Ag</li> <li>2a) This action is FINAL.</li> <li>2b) This</li> <li>3) Since this application is in condition for allowar closed in accordance with the practice under E</li> </ul>	action is non-final. nce except for formal matters, pro		ner <sub>i</sub> ts is
Disposition of Claims			
4) ⊠ Claim(s) <u>1 - 5, 7 - 13, 15 - 18 and 28 - 31</u> is/are 4a) Of the above claim(s) is/are withdraw 5) □ Claim(s) is/are allowed.  6) ⊠ Claim(s) <u>1 - 5, 7 - 13, 15 - 18 and 28 - 31</u> is/are 7) □ Claim(s) is/are objected to.  8) □ Claim(s) are subject to restriction and/o	vn from consideration.		
Application Papers			
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) accomposed and all accomposed and any not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Examine 11.	epted or b) objected to by the drawing(s) be held in abeyance. See ion is required if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 CFR	
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority document application from the International Bureau * See the attached detailed Office action for a list	s have been received. s have been received in Applicati rity documents have been receive u (PCT Rule 17.2(a)).	ion No ed in this National S	tage
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate	152)

## **DETAILED ACTION**

### Response to Amendment

1. Applicant's amendment filed on September 22, 2003 has been received and entered in the case.

### Claim Rejections - 35 USC § 112

- 2. The following is a quotation of the first paragraph of 35 U.S.C. 112:
  - The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.
- 3. Claims 1 and 10 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

One skilled in the art would not be reasonably apprised of how to make the invention, since the negative limitation "said metal resistor not being connected to said first interconnect metal layer" does not have basis in the original specification, i.e. there is no explicit teaching to this effect. This is a new matter rejection.

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### Claim Rejections - 35 USC § 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section-102 of this title, if the differences between the subject-matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 1, 7, 10, 15, 28 and 30 are rejected under 35 U.S.C. 103(a) as being unpatentable over Lee (U.S. Pat. No. 6,117,789) in view of Geller et al. (U. S. Pat. No. 5,929,510).

Regarding claims 1 and 10, Lee discloses in e.g., Fig. 1E an integrated circuit chip comprising:

- a first intermetallic dielectric layer (102) situated over a substrate (100);
- a metal resistor (104a) situated over said first intermetallic dielectric layer, said metal resistor not being connected to said first interconnect metal layer;
- a dielectric cap layer (106b) patterned on said metal resistor;
- a second intermetallic dielectric layer (108a) formed over said dielectric cap layer and metal resistor;
- a second interconnect metal layer (118a and 118b) over said second intermetallic dielectric layer;
- a first intermediate via (112d) connected to a first terminal of said metal resistor, said first intermediate via being further connected to a first metal segment patterned in said second interconnect metal layer;

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- a second intermediate via (112c) connected to a second terminal of a metal resistor, the second intermediate via being further connected to a second metal segment patterned in said second interconnect metal layer.

However, Lee does not disclose a first interconnect metal layer. Geller et al. teaches in e.g., Fig. 1 and column 2, line 67 – column 3, line 2 a first interconnect metal layer (22) under a first intermetallic dielectric layer (30) and a resistor (46). Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to modify Lee by adding the first interconnect metal layer under the first intermetallic dielectric layer and the resistor as taught by Geller et al. The ordinary artisan would have been motivated to modify Lee in the manner described above for at least the purpose of providing an RF filter or center conductor (column 3, lines 5 - 7).

Regarding claims 7 and 15, Lee discloses in e.g., Fig. 1E and column 3, line 11 the dielectric cap layer (106b) comprising silicon nitride.

Regarding claims 28 and 30, Lee discloses in e.g., Fig. 1E said metal resistor being not connected from below.

6. Claims 2 – 5, 8, 9, 11 – 13 and 16 – 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Lee and Geller et al. as applied to claims 1 and 10 above, and further in view of Zhao et al. (U. S. Pat. No. 6, 627, 539).

Lee discloses the claimed invention except for the material of the metal resistor to be tantalum nitride (claims 2 and 11); the material of the first interconnect metal layer comprising aluminum (claims 3 and 16); the material of the first intermetallic dielectric layer comprising

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HDPCVD silicon dioxide (claims 4 and 12); the material of the second intermetallic dielectric layer comprising undoped silica glass (claims 5 and 13); an oxide cap layer (claims 8 and 17); and the material of the oxide cap layer comprising PECVD silicon dioxide (claims 9 and 18). Zhao et al. teaches in e.g., Fig. 2L the material of a metal resistor (220, at the left-side) to be tantalum nitride (column 6, lines  $27 \sim 32$ ); the material of a first interconnect metal layer (204) comprising aluminum (column 4, lines 12 ~ 17); the material of a first intermetallic dielectric layer (205) comprising HDPCVD silicon dioxide (column 4, lines 18 ~ 38); the material of a second intermetallic dielectric layer (224) comprising undoped silica glass (column 4, lines 18 ~ 38); an oxide cap layer (222; column 7, lines  $17 \sim 20$ ) situating between a metal resistor and a dielectric layer; and the material of the oxide cap layer comprising PECVD silicon dioxide (column 7, lines  $17 \sim 20$ ). Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to further modify Lee by using the first interconnect metal layer to be tantalum nitride; the material of the first interconnect metal layer comprising aluminum; the material of the first intermetallic dielectric layer comprising HDPCVD silicon dioxide; the material of the second intermetallic dielectric layer comprising undoped silica glass; an oxide cap layer; and the material of the oxide cap layer comprising PECVD silicon dioxide as taught by Geller et al. The ordinary artisan would have been motivated to further modify Lee in the manner described above for at least the purpose of reducing resistivity and noise related to substrate coupling, and allowing an improved process window and simplifying the etching process (column 3, lines 20 - 28).

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7. Claims 29 and 31 are rejected under 35 U.S.C. 103(a) as being unpatentable over Lee and Geller et al. as applied to claims 1 and 10 above, and further in view of Ishii (U. S. Pat. No. 5, 422, 307).

Lee discloses the claimed invention except for the thickness of the metal resistor. Ishii teaches in e.g., Fig. 14D and column 9, lines 61 – 63 the thickness of a metal resistor (212) being 500 Angstrom. Thus, it would have been obvious to one of ordinary skill in the art at the time when the invention was made to further modify Lee by using the thickness of a metal resistor to be 500 Angstrom as taught by Ishii. The ordinary artisan would have been motivated to further modify Lee in the manner described above for at least the purpose of preventing a defective product due to bad connection and improving the yield (column 10, lines 36 - 38).

#### Response to Arguments

8. Applicant's arguments with respect to claims 1 and 10 have been considered but are moot in view of the new ground(s) of rejection.

#### Conclusion

9. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE

MONTHS from the mailing date of this action. In the event a first reply is filed within TWO

MONTHS of the mailing date of this final action and the advisory action is not mailed until after

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the end of the THREE-MONTH shortened statutory period, then the shortened statutory period

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will expire on the date the advisory action is mailed, and any extension fee pursuant to 37

CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

however, will the statutory period for reply expire later than SIX MONTHS from the date of this

final action.

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Chris C. Chu whose telephone number is 571-272-1724. The

examiner can normally be reached on 11:30 - 8:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Tom Thomas can be reached on 517-272-1664. The fax phone number for the

organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent

Application Information Retrieval (PAIR) system. Status information for published applications

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system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR

system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

10m / Norm

Chris C. Chu Examiner

TOM THOMAS
SUPERVISORY PATENT EXAMINER

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c.c. 7/9/04